



Docket No.: 4468-017

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Eiji KIMURA

U.S. Patent Application No. 09/877,202

Filed: June 11, 2001

For: OPTICAL CHARACTERISTICS MEASURING APPARATUS, METHOD AND RECORDING  
MEDIUM

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:  
: Confirmation No. 9531  
:  
: Group Art Unit: 2877  
:  
: Examiner: Tu T. Nguyen

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed more than three months after the U.S. filing date and after the mailing date of the first Office Action on the merits, but before the mailing date of the Final Rejection or Notice of Allowance.

A credit card authorization form in the amount of \$180.00 is attached. Any deficiency or overpayment should be charged or credited to Deposit Account No. 07-1337.

09/08/2004 HDEMESS1 00000094 09877202

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Respectfully submitted,

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**Date: September 7, 2004**

<div>INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)</div> <div>SEP 07 2004 TRADEMARK OFFICE</div>				ATTY. DOCKET NO. 4468-017		U.S. PATENT APPLICATION NO. 09/877,202	
				APPLICANT Eiji KIMURA			
				FILING DATE June 11, 2001		GROUP 2877	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
	4,551,019	11/1985	Vella <i>et al.</i>				
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation Yes No	
	0 280 328	08-1988	Europe				
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			

**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.